

<b>Notice of References Cited</b>	Application/Control No. 10/598,159		Applicant(s)/Patent Under Reexamination YOON, JI-WON	
	Examiner KATHRIEN CRUZ		Art Unit 1617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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**NON-PATENT DOCUMENTS**

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	U	Merck Index (Thirteenth Edition, 2001, pg 1021-1022).
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